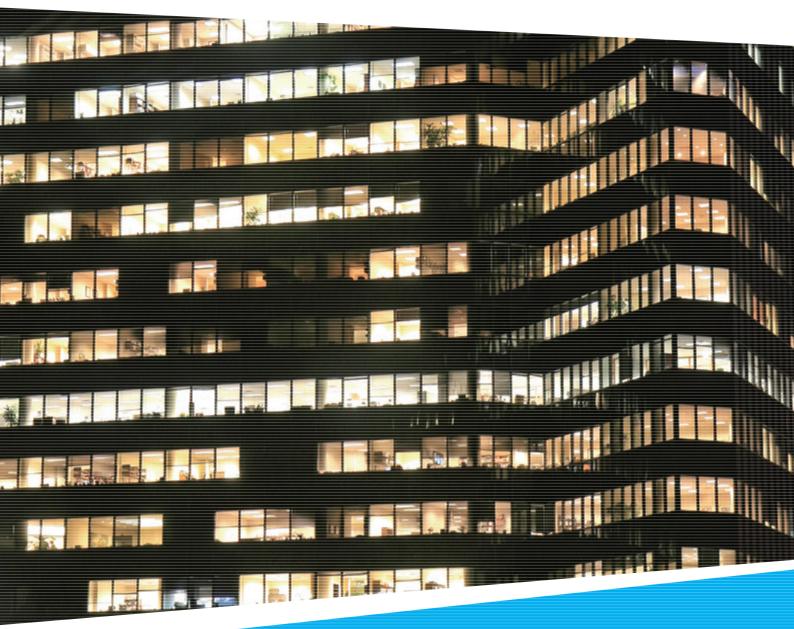
LED/Lighting Test Solution

www.chromaate.com

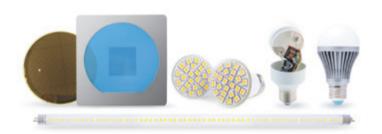




Turnkey Test & Automation Solution Provider







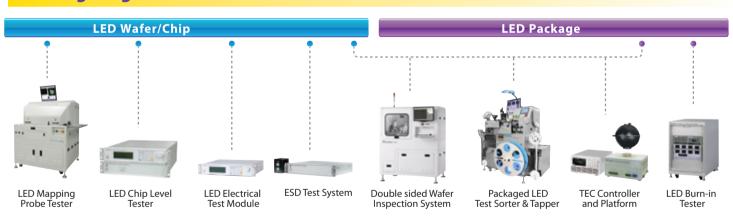
Founded in 1984, Chroma ATE Inc. is a world leading supplier of precision Test and Measurement Instrumentation, Automated Test Systems, Manufacturing Execution Systems and Turnkey Test and Automation Solutions marketed globally under the brand name "Chroma".

Significant markets Chroma serves include LED, photovoltaic, Li-battery, electric vehicle, semiconductor/IC, optical devices, flat panel display, video and color, power electronics, passive component, electrical safety, and thermoelectric test, as well as automated optical inspection and manufacturing execution systems.

Chroma's vision is to develop globally leading products as a world-class enterprise. To achieve this, Chroma devotes a significant amount of investment and resources in research and development in order to produce exceptional products of precision, reliability and valuable unique test solutions for technology industries. To sustain as a world-class enterprise, Chroma nurtures its brand as one of innovation, continuous improvement, and globalization ensuring its leading technology and integration capabilities in optics, mechanics, electronics, thermal control and software provide competitive advantages and future growth for the company.

Chroma has branch offices in Europe, the United States, Japan and mainland China chartered to deliver innovative technologies with high value-added service to satisfy our global customers' demands.

LED / Lighting Test Solution







LED Mapping Probe Tester

Model 58212-C

The Chroma 58212-C features an automated LED wafer/chip probe tester, delivering fast and accurate LED measurements with test times less than 125ms *1.

The system can be modified to support different LED structures including Lateral, Vertical, and Flip Chip designs. Integrated scanners provide autonomous wafer mapping to guarantee precision testing. The patented probe head prevents device scratches and ensures solid contact with every LED.

Chroma's unique design acquires and analyzes optical data such as the dominant wave length, peak wavelength, and CCT. Additionally, it provides essential electrical data such as forward voltage, leakage current, and reverse breakdown voltage, all in one test step.

The 58212-C includes a user-friendly graphical interface and advanced logic algorithms to significantly increase production efficiency. Comprehensive statistical reports and analysis tools allow for easy control and mass production management.

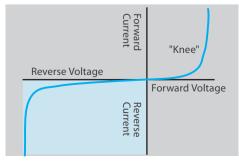
Note *1: Test condition: under 300um sample pitch, 5 electrical test parameters and 1 optical parameter. Due to differences in LED characteristics, the measurement results may vary.



- High speed and accuracy
- ✓ Lateral, vertical, and flip chip
- ✓ Wide power test range (up to 200V/2A)
- ✓ Up to 8 inch wafers
- Chroma® Huge Photo Detector
- Unique edge sensor
- Patented probe head
- Robust Z-Axis stage
- Wafer mapping algorithm
- External light shielding enclosure
- Analysis tools and statistical reports

Test Items

- Electrical parameters:
 - Forward Voltage Measurement (Vf)
 - Reverse Breakdown Voltage Measurement (Vrb)
 - Reverse Leakage Current (Ir)
 - SCR detection
- Optical parameters:
 - Optical power (mw, lm, mcd)
 - Dominant Wavelength (Wd)
 - Peak Wavelength (Wp)
 - Full Width at Half Maximum (FWHM)
 - CIExy CCT CRI

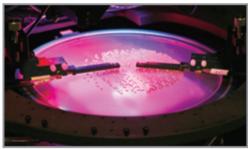


LED I-V curve

Hardwares

- ✓ Automatic LED wafer/Chip prober
- ✓ Electrical test module
- Optical test module
- Optional ESD test module





SPECIFICATIO	NS				
Model		58212-C			
Application					
Test Area		ψ 8 inch wafer			
Supported De	vice	Chip on wafer : 2", 4", 6", 8"			
(Chuck is devic	e selected)	Chip on tape : 2", 4", 6"			
Chuck Type		Lateral type, Vertical type, and Flip Chip type (Select one of them)			
Die Size		7 ~ 120 mil			
Pad Size		≧ 70 µ m			
Electrical Para	meter Measurement	ts			
Power Range		≤ 20W			
	Source Range	$\pm 10V/\pm 100V/\pm 200V$			
Voltage	Source Accuracy	0.05% + 0.03%F.S. / 0.05% + 0.03%F.S. / 0.05% + 0.03%F.S. *2			
voitage	Measure Range	±10V/±100V/±200V			
	Measure Accuracy	0.03% + 0.02%F.S. / 0.03% + 0.02%F.S. / 0.03% + 0.02%F.S. *2			
	Source Range	± 20 uA / ± 500 uA / ± 20 mA / ± 500 mA / ± 2 A			
	Source Accuracy	0.08% + 0.06%F.S. / 0.08% + 0.05%F.S. / 0.08% + 0.05%F.S. /			
Current		0.3% + 0.1%F.S. / 0.3% + 0.3%F.S *2			
Current	Measure Range	\pm 20uA / \pm 500uA / \pm 20mA / \pm 500mA / \pm 2A			
	Measure Accuracy	0.06% + 0.04%F.S. / 0.06% + 0.03%F.S. / 0.06% + 0.03%F.S. /			
		0.25% + 0.1%F.S. / 0.25% + 0.3%F.S. *1			
Optical Measu					
	Wavelength Rang	350 ~ 780 nm			
Spectrometer	Wp Repeatability	±0.5 nm			
Specia ometer	Wd Repeatability (380~780nm)	±0.3 nm			
Optical Power	Repeatability	±1%			
Operation	Temperature	20° ~ 30°			
Environment	Humidity	40% ~ 70%			
Facility Requirements					
Machine Dimension		980 mmx1160mmx1500 mm (does not include monitor and signal)			
Power Require	ment	Single phase, 220VAC \pm 10%, 50/60Hz, 20A			
Input Air		-0.2 Mpa / ψ 6 mm			
Weight		750 kg			

Note *1: Test condition is under point of sensing

Note *2: The tested device is blue LED chip

بنيز

LED Chip Level Tester

Model 58173-TC

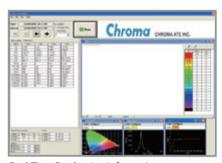
The LED Test System Model 58173-TC focuses on LED wafer/chip characteristics analysis and provides optimized test performance. Its test items include a variety of voltage/current output measurement, optical power measurement, and spectrum analysis. On measurement, several electrical and optical characteristics analysis can be achieved at a time within 25 ms, and its electrical measurement supports high-voltage LED and high-brightness LED applications.

On system integration, the 58173-TC can easily integrate various Probers and Handlers for wafer probing and chip sorting. In addition, optional switch module allows test system to perform multi-channel and multi-chip measurements.



Key Features

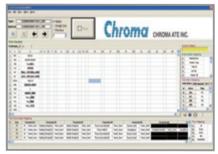
- High test speed: complete whole test within 25ms (selected test items)
- ✓ Super statble of temperature variation
- Support high voltage and high power LED test requirement
- ✓ Support multi-die test (option)
- ✓ Support ESD test (option)



Real-Time Production Information

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Flexible Editable Test Parameters



Powerful Report File Editing

SPECIFICATION	15	
Model		58173-TC
Parameters		
Electiral Test Items		Forward Voltage(Vf), Reverse Leakage Current (Ir), Reverse
Liectifal fest fter	113	Breakdown Voltage (Vrb), SCR
		Luminous Intensity (mcd), Lumen (lm), Radiant power (mw),
Optical Test Iten	ns	Dominant Wavelength (Wd), Peak Wavelength (Wp), FWHM,
		CIE Chromaticity, CCT, CRI
Electrical Parar	neter Measurements	
Power Range		\leq 20W, as the figure shows on next page
	Source Range	$\pm 10V / \pm 100V / \pm 200V$
Voltage	Source Accuracy	0.05% + 0.03%F.S. / 0.05% + 0.03%F.S. / 0.05% + 0.03%F.S. *1
voitage	Measurement Range	±10V/±100V/±200V
	Measurement Accuracy	0.03% + 0.02%F.S. / 0.03% + 0.02%F.S. /0.03% + 0.02%F.S. *1
	Source Range	±20uA / ±500uA / ±20mA / ±500mA / ±2°
	Source Accuracy	0.08% + 0.06%F.S. / 0.08% + 0.05%F.S. / 0.08% + 0.05%F.S. /
Current		0.3% + 0.1%F.S. / 0.3% + 0.3%F.S *1
Current	Measurement Range	± 20 uA / ± 500 uA / ± 20 mA / ± 500 mA / $\pm 2^{\circ}$
	Measurement Accuracy	0.06% + 0.04%F.S. / 0.06% + 0.03%F.S. / 0.06% + 0.03%F.S. /
	Weasurement Accuracy	0.25% + 0.1%F.S. / 0.25% + 0.3%F.S. *1
Optical Measur	rements	
Spectrometer	Wavelength Rang	350 ~ 780 nm
Spectrometer	Detector Pixels	2048 pixels
Wp	Repeatability *2	±0.5 nm
Wd	Repeatability *2	±0.2 nm
(380~780nm)	nepeatability 2	_ U.Z IIIII
Radiant Flux	Repeatability *2	±1%
(mW)	nepeatability "2	<u>-</u> 170
Operation	Temperature	20°~ 30°
nvironment Humidity		40% ~ 70%
Facility Require	ements	
Power Requiren	nent	800 VA
Dimensions (M)	w D v II)	Electrical Test Module : 486 mm x 462 mm x 110 mm
Dimensions (W	х (х П)	Optical Test Module : 486 mm x 475 mm x 110 mm
Weight		15 kg

Note *1: Test condition is under point of sensing

Note *2: The tested device is blue LED chip

Ordering Information

58173-TC: LED Chip Level Tester

Optical Fiber : UV-VIS / 0.25m~2m / ψ 100~600nm

Optical Attenuation Module
Solar Cell Photo Detector (optional)
Integrating Sphere (2"~4") (optional)
Industrial Personal Computer
Four channels Switching Box

LED Electrical Test Module

Model 58221-200-2

Chroma 58221-200-2 is a module specially designed to test the electrical features of LED in full range. It has all functions required for testing the LED electrical features. The 58221-200-2 supplies high accuracy current source up to $\pm 200\text{V}/\pm 120\text{mA}$ for High voltage (HV) and up to $\pm 10\text{V}/\pm 2\text{A}$ for High Power (HP). Besides the standalone operation the 58222-200-2 is featured in, the USB interface and other integrated design can also be applied for synchronous measurement.

Key Features

- ✓ Focuses on LED test application
- ☑ Cover High Voltage (HV) and High Power (HP) LED test requirement
- ☑ Build-in hardware sequencer
- ☑ Build-in program memory and data memory
- ✓ Support LED SCR characteristic detect function

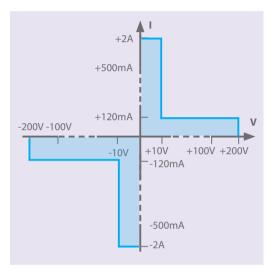
Test items

- ✓ Forward voltage (Vf)
- Reverse breakdown voltage (Vrb) Leakage (Ir)
- ✓ LIV
- ✓ I-V characterization









Wide voltage/current test range

SPECIFICATIONS					
Model	58221-200-2				
Current Source Accuracy					
Range	Programming Resolution	Source Accuracy $23^{\circ}\text{C} \pm 5^{\circ}\text{C}$ $\pm \text{(Reading + Range)}$	Default Measurement Resolution	Measurement Accuracy 23°C ± 5°C ± (Reading + Range)	
± 20 μ A	1nA	0.05% + 0.04%	1nA	0.05% + 0.04%	
\pm 500 μ A	50nA	0.05% + 0.04%	50nA	0.05% + 0.04%	
±20mA	1 μ Α	0.05% + 0.04%	1 μ Α	0.05% + 0.04%	
±500mA	50 μ A	0.08% + 0.04%	50 μ A	0.08% + 0.04%	
±2A	100 μ A	0.05% + 0.1% (≥0.1A range) 0.1% + 0.3% (<0.1A range)	100 μ A	0.05% + 0.1% (≥0.1A range) 0.08% + 0.1% (<0.1A range)	
Voltage Source Accuracy					
Range	Programming Resolution	Source Accuracy $23^{\circ}C \pm 5^{\circ}C$ $\pm (Reading + Range)$	Default Measurement Resolution	Measurement Accuracy 23°C±5°C ±(Reading + Range)	
±10V	1mV	0.03% + 0.02%	1mV	0.03% + 0.02%	
±100V	10mV	0.03% + 0.02%	10mV	0.03% + 0.02%	
±200V	10mV	0.03% + 0.02%	10mV	0.03% + 0.02%	
General Specification					
Interface		USB/Sta	nd alone		
Trigger	Available				
RAM (16 bits)	16M				
Operatoin Environment	0° C \sim 5 $^{\circ}$ C (32 $^{\circ}$ F \sim 122 $^{\circ}$ F); Humidity: < 70% R.H. Non-condensing				
Max. Power Consumption (VA)	120VA				
Dimensions (WxHxD)	432x110x432 mm				
Weight (kg)	10				

ESD Test System

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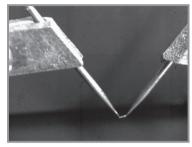
Model 58154 Series

Chroma 58154 series ESD (Electrostatic Discharge) Test Systems are PCI controlled module to simulate electrostatic discharge pulse during electronic device testing. The 58154 series offer both ANSI/ESDA/JEDEC JS-001-2014-Human Body Model and ANSI/ESD STM 5.2-2012-Machine Model. The user friendly software offers programmable and flexible features, such as sampling test on a wafer, ESD model, ESD pulse polarity, ESD pulse interval in a sequence, and automatic testing function.

The 58154 series includes a control module and a pulse output external box. High voltage power supply unit (PSU) and pulse shaping circuits provide the ESD standards compliant pulse waveform.

The 58154 series offer a flexible and total ESD test solution to customers. Furthermore, the ESD pulse is generally applied to the device under test before measuring device electric parameters and the 58154 series can be perfectly integrated with Chroma 58212-C to provide a total solution in production line.

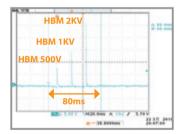




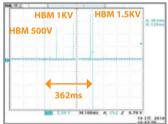
ESD Test on LED chip

Key Features

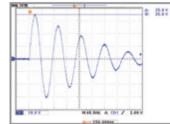
- Two models ESD pulse generation: human body model and machine model
- ✓ Programmable auto test: pulse delay, cycle and polarity are programmable
- ☑ Resolution (58154): 5V per-step for machine model, 20V per-step for human body model
- ☑ Resolution (58154-B): 10V per-step for machine model, 30V per-step for human body model
- ☑ Resolution (58154-C): 10V per-step for machine model, 30V per-step for human body model
- ☑ Diversity control interface : PCI DIO card
- ✓ Up to 8000V (58154-C)



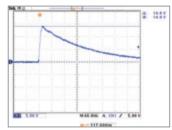
New Function and improvement - 3 HBM pulses within 80 ms



Traditional way -3 HBM pulses within 362 ms



Machine Model waveform



Human Body Model waveform

SPECIFICATIONS			
Model	58154	58154-C	
Parameter		Value	
ESD Mode		Machine Model / Human body model	
Pulse Voltage	Machine model: 50V to 400V \pm 5V	Machine model: 100V to 800V \pm 10V	Machine model: 100V to 800V \pm 10V
ruise voitage	Human body model: 250V to 4KV \pm 20V	Human body model: 250V to 6KV \pm 30V	Human body model: 250V to 8KV \pm 30V
ESD Specification *1 *2	Machine model reference on STM5.2-2012 ; Human body model reference on ANSI/ESDA/JEDEC JS-001-2014		
Pulse Interval	20 ms to 1 s (User definable)		
Pulse Repetition	Single or multiple		
Pulse Polarity	Positive or negative (software control)		
AC Input	100 to 240V, 47 to 63 Hz		
Dimensions	434.6mm(W) x 97.7mm(H) x 306.8mm(D) 434.6mm(W) x 97.7mm(H) x 450mm(D)		
Weight	12 kg		

Pattern No.: I311648, I398655, ZL 2009 2 0148342.2

Pattern Name: Discharge and remote feedback integrated testing system

Note*1: The test condition is under Chroma's probe tips

Note*2: The accuracy of Chroma 58154 may vary in customer's setup conditions. To fix this problem, ESD tester needs to be tuned the value of the impedance to minimized waveform distortion, or customers provide their setup information in advance and Chroma tunes ESD testers before shipment to fit customer's test method.

LED Burn-in Tester

Model 58266

Chroma 58266 is a LED Burn-in Tester that each channel can offer a constant current up to 500mA but also has 0~400V voltage measurement function. For product application, various programmable power supplies can be applied for multi-channel constant current output and voltage measurement. The user can integrate several power supplies based on the demands of channels and current for multi-channel test.

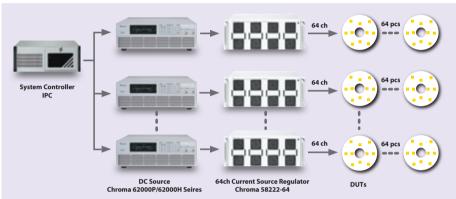
Key Features

- ☑ Flexible channels output: 32/64/128 channels
- ☑ Each channel can offer up to 500mA /400V
- ✓ Each channel can parallel connection for high current requirement. Ex: 2-ch: 1A, 4-ch: 2A
- High accuracy of current output and voltage measurement

System Architecture

- DUT: single LED, LED array, LED light bar or LED module
- ☑ Support channels: 64 ch
- ☑ Force Current: Max. 500mA per-channel
- ☑ Support parallel connection: Ex: 2-ch: 1A
- ✓ Voltage measurement: Max. 400V





CONFIGURATION				
Programmable	LED Burn-in Tester	Force	Measure	
DC Power Supply	LED Burn-in Tester	l range	V Range	
Model 62012P-40-12	Model 58266	500mA	30V	
40V/120A/1200W	Model 58266	400mA	35V	
Model 62012P-100-50	Model 58266	500mA	32V	
100V/50A/1200W	Model 58266	170mA	95V	
Model 62024P-80-60	Model 58266	500mA	70V	
80V/60A/2400W	Model 58266	440mA	75V	
Model 62024P-100-50	M - d - 1 50266	500mA	70V	
100V/50A/2400W	Model 58266	350mA	95V	
Model 62024P-600-8	Madal 50266	110mA	300V	
600V/8A/2400W	Model 58266	80mA	400V	
Model 62050P-100-100	M - d - 1 50266	500 A	051/	
100V/100A/5000W	Model 58266	500mA	95V	
Model 62050H-450 450V/34A/15KW (380V/3 Ф 4W)	Model 58266	500mA	400V	

SPECIFICATIONS SPECIF							
Model	58266						
Voltage Accuracy (23°C±5°C)							
Range	0~4V		0~4	40V		0~400V	
Default Measurement Resolution	1mV		10	mV		100mV	
Measure Accuracy \pm (%rdg. + offset)	0.2%+5mV		0.2%+	-50mV		0.3%+500mV	
Current Accuracy (23°C±5°C)							
Range	10 μ A		1mA	100mA		500mA	
Programming Resolution	5nA		500nA	50 μ A		200 μ A	
Source Accuracy \pm (%rdg. + offset)	0.1%+20nA	0.	1%+300nA	0.1%+200 µ	ΙA	0.2%+1mA	
Temperature Coefficient	10	~18°C &	28~50°C; ±(0.5	imes accuracy speci	fication).	/°C	
Max. Voltage Difference of all Channel	10V @ 500mA ; 50V @ 100mA ; 100V @ 50mA						
Operation Environment	Temperature: 10~50°C; Humidity: 10~70%RH						
Storage Environment		Tem	perature : -20~70	°C ; Humidity : 5°	~95%RH		

Packaged LED Test Sorter & Tapper

Model 58270/58280

With rise of Green Energy, LED, with its high energy efficiency and reliability, has played important role in energy saving. Despite LED light, many modern electronics applications are also increasingly using LED because of its energy saving feature, such as backlight of LCD monitor, TV and mobile devices. This results continue growth of demand in, not only volume but also new innovations in packaged LED.

LED tester/sorter is equipment used to test and sort (white) packaged LEDs then sort them into different specs that are defined by customers. However, with new type of LED packaging technologies, primarily CSP (Chip Scale Packing), they brings new challenges to the conventional packaged LED Tester/Sorter design.

Unlike conventional white packaged LEDs which package Blue LED chips into plastic mold with metal lead frame and dispense phosphor to give desired white color, CSP LED dispense the phosphor directly on Flip-Chip type of LED wafer therefore, no additional packaging process is need. Plus, removing the plastic mold, it provides wider light emitting angle which highly desirable for backlight application. However, the CSP LED and its unique structure make probing lot difficult then conventional packaged LED. Also, lacking of plastic mold and lead frame, it is structurally more fragile than conventional packaged LED.

Chroma 58270 Packaged LED Tester/ Sorter was designed to meet all of the challenges brought by conventional and new type of CSP LED. Bin numbers can be custom-designed up to 256 bins. Innovative probing mechanism provides highly repetitive probing quality; Specially designed low stress bowl feeder guarantees minimum chipped chips; Optional optical inspection secure no fail devices go to pass bins. to provide high speed, high accurate yet high yield of testing & sorting solution.

For some manufacturing process alignments, Packaged LED Tester/Sorter may require to combine with Tapper so the main bin can be tapped into reel directly. Chroma 58280 is designed to combine LED Tester, Sorter and Tapper into one integrated system with all features available in Chroma 58270 (except bin numbers).

Key Features

- ✓ High testing/sorting speed: Up to 42k/48k LEDs per hour (58270)
- ✓ Fully configurable test stations
- Complete optical and electrical test functions including: CIE x,y, CCT, mW, Lumen, Vf, Ir etc.
- Auto polarity detection and orientation correction
- High accurate SMU and temperature controlled spectrometer provide highest measurement repeatability under any environment.
- Super low stress bowl feeder provides highest yield
- Optional optical inspection secures no chipped chips or chips with stains go into pass bins
- ✓ Up to 512/36 (58270/58280) customer definable bins
- Packaged type supported: 1313 CSP, 1616 CSP, 0603, 0606, 0608, 1005, 1608, 1612, 1615, 2012, 3010, 3014, 3030, 3216, 3303, 3528, 4014, 5050, 5630, 7020, 7030, 8520; other types available upon request
- ✓ High speed tapping (58280)
- ✓ Versatile graphical user interface



Tapper 58280



Packaged LED Tester/ Sorter 58270



LED Packaged Lavel Tester 58174

Model	58270	58280	
Throughput (UPH)	up to 48k (0603) *1	up to 48k (0603) *1	
LED Type	1313 CSP, 1616 CSP, 0603, 0606, 0608, 1005, 1608, 1612, 1615, 2012, 3010, 3014, 3030, 3216, 3303, 3528, 4014, 5050, 5630, 7020, 7030, 8520; other types available upon request		
Bin Number	up to 256	up to 37	
Optical Inspection	optional	optional	
LED Tester	Chroma 58174 LED Tester	Chroma 58174 LED Tester	
LED Reel Type	void	carrier tape	
Dimension (HxWxD)	1,680mm x 850mm x 1,400mm	1,800mm x 1,000mm x 1,500mm	
Weight	approx. 450 kg	approx. 300 kg	
Input Power	220V; 5	50/60Hz	
Environment	18~28°C; < 70%RH		
Utility Requirement	Air pressure: >4~≦5kg/cm²	Air pressure: >4~ ≦ 5kg/cm ²	
othity nequirement	Vacuum Input: 20~60 kpa	Vacuum Input: 20~60 kpa	

Note *1: Actual UPH may vary based on distribution of the bins.

Note *2: The tested device is blue LED chip

SPECIFICATIONS		
Model		58174
Parameters		
EL		Forward Voltage(Vf), Reverse Leakage Current (Ir),
Electiral Test Items		Reverse Breakdown Voltage (Vrb), SCR
		Luminous Intensity (mcd), Lumen (lm), Radiant power (mw), Dominant Wavelength (Wd), Peak
Optical Test Items		Wavelength (Wp), FWHM,
		CIE Chromaticity, CCT, CRI
Electrical Parameter N	/leasurements	
Power Range		≦ 20W
	Source Range	±10V/±100V/±200V
Valtaria	Source Accuracy	0.05% + 0.03%F.S. / 0.05% + 0.03%F.S. / 0.05% + 0.03%F.S. *1
Voltage	Measurement Range	$\pm 10V / \pm 100V / \pm 200V$
	Measurement Accuracy	0.03% + 0.02%F.S. / 0.03% + 0.02%F.S. /0.03% + 0.02%F.S. *1
	Source Range	$\pm 20uA / \pm 500uA / \pm 20mA / \pm 500mA / \pm 2^{\circ}$
Current	Source Accuracy	0.08% + 0.06%F.S. / 0.08% + 0.05%F.S. / 0.08% + 0.05%F.S. / 0.3% + 0.1%F.S. / 0.3% + 0.3%F.S *1
Current	Measurement Range	$\pm 20uA / \pm 500uA / \pm 20mA / \pm 500mA / \pm 2^{\circ}$
	Measurement Accuracy	0.06% + 0.04%F.S. / 0.06% + 0.03%F.S. / 0.06% + 0.03%F.S. / 0.25% + 0.1%F.S. / 0.25% + 0.3%F.S. *1
Optical Measurement	s	
Spectrometer	Wavelength Rang	350 ~ 780 nm
Spectrometer	Detector Pixels	2048 pixels
CIExy Repeatability		±0.0015
Wp	Repeatability	$\pm 0.5\mathrm{nm}$
Wd (380~780nm)	Repeatability	\pm 0.2 nm
Radiant Flux (mW)	Repeatability	±1%

Note *1: Test condition is under point of sensing

Note *2: The tested device is cool white LED

Note *3: The tested device is blue LED chip





Flexible Editable Test Parameters

Real-Time Production Information

Powerful Report File Editing



LED Light Bar Test System

Model 58182

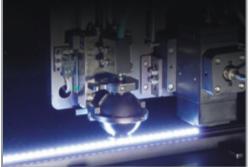
Chroma 58182 LED Light Bar Test System is a fully automatic test system able to measure the top-view/side-view light bar uniformity composed of white light or RGB LED. With image recognition function, it can accurately capture the location of LED and identify the center of LED under the measurement. With automatic mechanical and optical measurement function, the 58182 can perform extremely accurate optical and electrical measurement.

The 58182 integrates image recognition function, automatic mechanical and optical measurement. It can not only improve the yield rate by sifting out the defect products, but also reduce the product verification time and development cost. In addition, the 58182 has a flexible measurement platform to adapt different type of top-view / side-view LED light bar measurement, and friendly user interface to reduce user's learning time. Consequently, the 58182 is the best choice for testing top-view/side-view light bar.

Key Features

- Measure the top-view/side-view light bar uniformity composed of white light
- Equipped with image recognition function to capture the LED location accurately
- Excellent optical performance
- ☑ ESD damaged sorting function
- ✓ FPC/PCB light bar adaptability









CIE127 Condition B measurement Module

SPECIFICATIONS					
Model		58182			
Optical Module		CIE 127 condition	n B optical tube or Partial flux meas	surement module	
	Range	100~10000mcd			
Average Intenstive (mcd)	Accuracy		±5%		
	Repeatability		±2%		
CIE x, y	Accuracy		±0.004		
CIE X, y	Repeatability		±0.002		
	Wavelength Range		380~780nm		
Spectrumeter	Optical resolution	2nm			
	A/D	16 bits			
Light Bar length		600mm			
Offer Channels		20 X 12 Ch			
	Voltage	0~200V	0~60V	0~300V	
Power Supply	Current	10uA~5mA	1mA~2A	40mA~2A	
rower supply	Voltage accuracy	0.3%+0.1%F.S	0.01%+10mV	0.05%+0.05%F.S	
	Current accuracy	0.3%+0.1%F.S 0.01%+1mA 0.03		0.03%+40mA	
Data output	Format	Excel (*.csv)			
	Output items	mcd, CIEx, CIEy			
XY moving range		600x250mm			
Dimension		1300 (D) × 2360 (W) × 1815 (H)mm			

LED Light Bar Electrical Test System

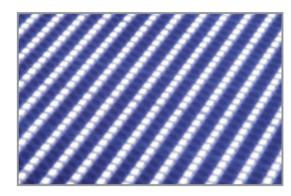
Model 58183

Chroma 58183 is a PC base test system for LED light bar electrical test. In hardware design, Chroma 58183 not only offers a accurately current (10uA~5mA) to test LED electrical features but also can integrate an extra high power supply for high current test. Otherwise, Chroma 58183 offers multichannels test function. It is widely used in many application. In LED light bar manufactory, 58183 can test more 10 pieces Light bar at the one time. In LED backlight manufactory, 58183 can test 4 pieces LED backlight via a 4 channels control box. To sum up, 58183 is a very strong and powerful tool for LED light bar and LED backlight manufactories.

Key Features

- ✓ Integrating customer's extened power supply
- PC base design
- ✓ Support multi- channels test
- ☑ Using general DUT adapter to offer test application widely
- ✓ Software support authority managerment





SPECIFICATIONS				
Model	58183			
Voltage				
Output Range	10V / 100	OV / 200V		
Source Accuracy *1	0.05% +	0.03% F.S		
Measure Accuracy *1	0.03% +	0.02% F.S		
Current				
Output Range	20uA/500uA/	20mA/500mA		
Source Accuracy *1	0.1% +	0.1% F.S		
Measure Accuracy *1	0.1% +	0.1% F.S		
Applicative Type	Top/side-view	LED light bar		
	IPC : 451 x	426.5 x 177		
Dimensions	Relay Box : 276 x 430 x102			
	Chroma 58221 : 432 x 432 x 110 (D x W x H mm)			
	Total	27 Kg		
Weights	(IPC 12Kg, Relay Box 5Kg, Chroma 58221-200-2 10Kg)			
Relay Box (Not in live wire)	(12.13, 10.0)			
,	Ch1~24 Ch25~32			
Switch voltage	200VDC	300VDC		
Carry current	300mA	600mA		
Life expectancy of mechanical	10^6	10^6		
Power IN Power IN				
IPC, Chroma 58221-200-2	90-240VAC			
Relay Box	110 / 220V,50~60Hz, 2A			
Others				
General purpose relay	32 Channels			
0	Temperatu	re:10~40°C		
Operation environment	Humidity:10%~70%			

Ordering Information

58183: LED Light Bar Electrical Test System **58221-200-2**: LED Electrical Test Module

Relay Box

Industrial Personal Computer



LED Lighting Test System (For Laboratory)

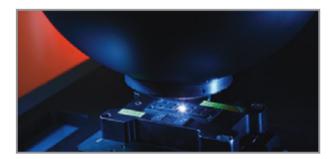
Model 58158

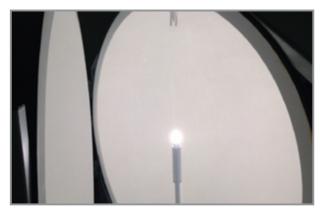
Chroma 58158 LED Lighting Test System, compliances the AC LED Device National Standard, has integrated Chroma's Power Electronics Test Equipment - Programmable AC Power Source and Digital Power Meter to offer users a real AC environment for measuring AC LED.

Furthermore, the 58158 also integrates Chroma DC Power Supplies with the flexible optical test platform which equips with integrating sphere, photo detector, and etc.. Users can measure optical and electrical parameters of AC/DC LED through a friendly softtware interface.

Key Features

- ☑ Simulate the real AC test condition and environment
- ☑ Integrate AC, DC, and optical features test to one platform
- ✓ Support DC test for AC LED
- ✓ Support dual-optical test module in one platform (Integrating sphere or average intensity) (optional)
- ✓ Support AC /DC LIV analysis
- ✓ Offer standard light source for calibration





For Laboratory Test

Optional Integrating Spheres









Model	cm Integrating Sphere)	58158
Measurement Items		30130
Optical Measurement Items		Lumens (lm), CIE(x,y)), CIE(u',v'), CCT, CRI
Electrical Measurement Items		Frequency, Real power P, power factor PF, THD (Option), Vf (Option)
Optical Measureme	nt	
Photo	Wavelength Range	380~780nm
Detector	Lumens Range *1	<5,000 lm (>5K lm optional)
· · · · · · · · · · · · · · · · · · ·	Detector Type	2048 Pixels Linear CCD array (optional)
Spectrometer	Optical Fiber Connector	SMA 905
umen accuracy		±5%
CIExy accuracy		±0.004
umen Repeatability	*2	±0.5%
IExy Repeatability *:	2	±0.0005
Electrical AC Source		
Output Rating-AC		500VA
	Range/Phase	150V/300V/Auto
	Accuracy	0.2%+0.2%F.S.
/oltage	Resolution	0.1V
3	Line Regulation	0.10%
	Load Regulation	0.20%
4 6 . (8)	RMS	4A/2A (150V/300V)
Max.Current / Phase	peak	24A/12A (150V/300V)
lectrical AC Meter		
ower	Range (W)	1.5W~1KW (Model 66201); 1.5W~10KW (Model 66202)
ower	Power Factor Accuracy *3	0.006+(0.003/PF)KHz
Harmonic	Range	2~50 order
OC Measurement (O	optional)	
	Output Voltage	0~64V (> 64V optional)
	Output Current	0~3A (> 3A Optional)
	Ripple and Noise	1400 uVrms & 14 mVp-p / < 1mA
OC Power	Line Regulation	0.01% +4mV / 0.01% + 300 μ A
Supply	Load Regulation	< 6mV / 0.01% + 300 μ A
	Program Accuracy	0.02% + 10mV / 0.01%+1mA
	Read back Accuracy	0.02% + 10mV / 0.01%+1mA
Others	,	
Dimension (H x W x D	0)	1081 x 532 x 700 mm
Veight		100k g
Power Consumption		300 W
Operating		100~240V VAC 50/60HZ
Software Support D	C Source	

Chroma 6200P-300-8, Chroma 11200 (650V), Chroma 11200 (800V), Keithley 24XX Series

Notes *1: 20 inch Integrating Sphere

Notes *2: The unit under test is 10W halogen lamp

Notes *3 : The PF spec. applies only when the signals are higher then 50% of the selected voltage and current ranges

ORDERING INFORMATION

Integrating sphere	50cm	1m	2m
Luminaire	small lamp, bulb, MR-16	middle lamp, 2 feet T8/T5 tube	large lamp, 4 feet T8/T5 tube, street light
Application	laboratory	laboratory	laboratory

Note: Customization for 3m integrating sphere

LED Lighting In-line Test System (For Production)

Model 58158-SC

The design concept of Chroma LED high speed measurement module is to combine several large size detectors and add up the luminous flux obtained by each detector to calculate the total flux of LED light. This design not only overcomes the shortcoming of previous inconvenient measurement for total flux by conventional integrating sphere, it also implements the inline test on production line. Chroma is able to provide the customer a fully automatic production line that covers both quality and productivity.

Key Features

- Mass production application: LED lamp, LED bulb, LED bar, LED streetlight, and other luminaries
- Less error comparing to integrating sphere measurement
- ☑ High speed test and flicker measurement
- Provide standard light source for calibration which is international standard traceable
- ✓ Thermal control fixture adaptable (option)

Test Items

- Optical power characteristics : Lm, lm/w, LED operating frequency (Flicker)
- Color characteristics : CIExy, Duv, CIEu'v', CCT, CRI
- Power characteristics :

AC mode: Power Factor (PF), Irms, Vrms, THD

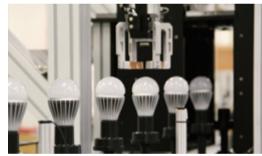
DC mode: Forward voltage



Instruments



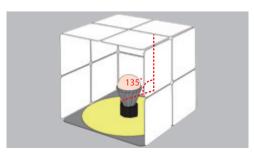




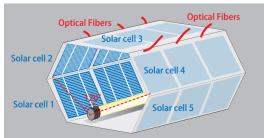








Solar Cell Module for Omnidirectional lamp



Solar Cell Module for JEL 801 LED Tube

PECIFICATIONS			
Model		58158 -SC	
Aeasurement Items			
Optical Measurement Items		Lumens (lm), CIE(x,y)), CIE(u',v'), CCT, CRI	
Electrical Measurement Items		Frequency, Real power P, power factor PF, THD (Option), Vf (Option)	
Optical Measurement			
Photo Detector	Wavelength Range	380~780nm	
	Lumens Range	<5,000 lm (>5K lm optional)	
Spectrometer	Detector Type	2048 Pixels Linear CCD array	
	Optical Fiber Connector	SMA 905	
Lumen measurement Repeatability		±0.5%	
CIExy Repeatability *1		±0.0005	
CCT Repeatability		±5K	
CRI Repeatability		±1	
lectrical AC Source			
Output Rating-AC		500VA	
	Range/Phase	150V/300V/Auto	
	Accuracy	0.2%+0.2%F.S.	
oltage	Resolution	0.1V	
	Line Regulation	0.10%	
	Load Regulation	0.20%	
Max.Current / Phase	RMS	4A/2A (150V/300V)	
	peak	24A/12A (150V/300V)	
lectrical AC Meter			
iectifical AC Meter	Range (W)	1.5W~1KW (Model 66201) ; 1.5W~10KW (Model 66202)	
Power	Power Factor Accuracy *2	0.006+(0.003/PF)KHz	
Harmonic	Range	0.006+(0.003/PF)KHZ 2~50 order	
		2*30 Oldel	
OC Measurement (Option		O CAN (> CAN antique)	
DC Power Supply	Output Voltage	0~64V (> 64V optional)	
	Output Current	0~3A (> 3A Optional)	
	Ripple and Noise	1400 uVrms & 14 mVp-p / < 1mA	
	Line Regulation	0.01% +4mV / 0.01% + 300 μ A	
	Load Regulation	< 6mV / 0.01% + 300 μ A	
	Program Accuracy	0.02% + 10mV / 0.01%+1mA	
	Read back Accuracy	0.02% + 10mV / 0.01%+1mA	
Others		1004 532 700	
Dimension (H x W x D)		1081 x 532 x 700 mm	
Weight		100kg	
Power Consumption		300 W	
Operating		100~240V VAC 50/60HZ	

Notes *1: The unit under test is 10W halogen lamp

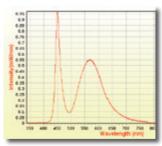
Software Support DC Source

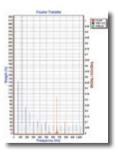
Notes *2: The PF spec. applies only when the signals are higher then 50% of the selected voltage and current ranges

Chroma 58221-200-2, Chroma 6200P-300-8, Chroma 11200 (650V), Chroma 11200 (800V), Keithley 24XX Series

Analysis Tools



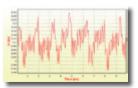


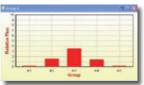


Power Analysis : Im, Im/W, PF, Power

LED Spectrum Analysis : CCT, CRI, Duv

THD Analysis





Flicker Analysis

Flicker Analysis

Chroma

